

20V N+N-Channel Enhancement Mode MOSFET

Description

The AP8804DF uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = 20V$ $I_D = 40A$

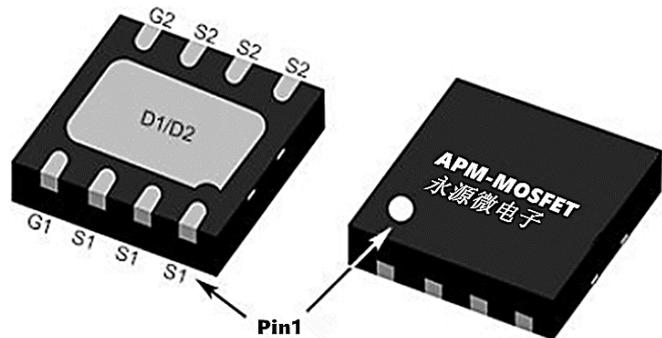
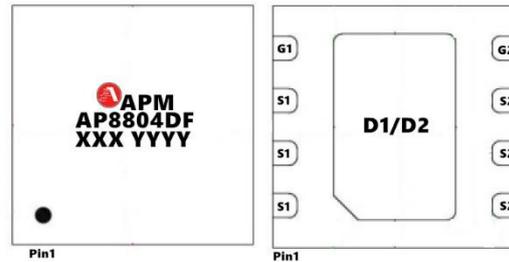
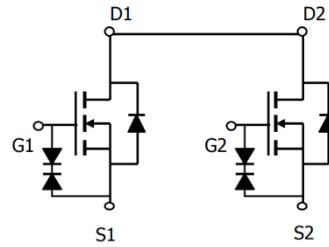
$R_{DS(ON)} < 6m\Omega$ @ $V_{GS}=4.5V$ (Type: 4.2m Ω)

ESD=2500V HBM

Application

BMS

Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP8804DF	QFN3X3-8L	AP8804DF XXX YYYY	5000

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	± 12	V
$I_D@T_A=25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 4.5V^1$	40	A
$I_D@T_A=70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 4.5V^1$	35	A
I_{DM}	Pulsed Drain Current ²	120	A
IAS	Avalanche Current	30	A
$P_D@T_A=25^\circ\text{C}$	Total Power Dissipation ¹	1.56	W
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	80	$^\circ\text{C}/\text{W}$

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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	VGS=0V , ID=250uA	20	22		V
RDS(ON)	Static Drain-Source On-Resistance ²	VGS=4.5V , ID=3A		4.2	6.0	mΩ
RDS(ON)	Static Drain-Source On-Resistance ²	VGS=2.5V , ID=3A		5.5	6.5	
VGS(th)	Gate Threshold Voltage	VGS=VDS , ID =250uA	0.5	0.7	1.2	V
IDSS	Drain-Source Leakage Current	VDS=20V , VGS=0V , T _J =25°C	---	---	1	uA
		VDS=20V , VGS=0V , T _J =55°C	---	---	5	
IGSS	Gate-Source Leakage Current	VGS=±12V , VDS=0V	---	---	±10	uA
gfs	Forward Transconductance	VDS=5V , ID=3A	---	42	---	S
Qg	Total Gate Charge (4.5V)	VDS=10V , ID=3A	---	38	---	nC
	Total Gate Charge (3.9V)		---	33	---	
Qgs	Gate-Source Charge		---	4.5	---	
Qgd	Gate-Drain Charge		---	12	---	
Td(on)	Turn-On Delay Time		VDD=10V , VGS=4.5V , RG=6Ω ID=3A	---	22	
Tr	Rise Time	---		41	---	
Td(off)	Turn-Off Delay Time	---		77	---	
Tf	Fall Time	---		21	---	
Ciss	Input Capacitance	VDS=10V , VGS=0V , f=1MHz	---	3165	---	pF
Coss	Output Capacitance		---	380	---	
Crss	Reverse Transfer Capacitance		---	325	---	
IS	Continuous Source Current ¹	VG=VD=0V , Force Current	---	---	40	A
ISM	Pulsed Source Current ²		---	---	100	A
VSD	Diode Forward Voltage ²	VGS=0V , IS=3A , T _J =25°C	---	---	1.2	V

Note :

- 1、 The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3、 The EAS data shows Max. rating . The test condition is VDD=45V,VGS=10V,L=0.1mH,IAS=30A
- 4、 The power dissipation is limited by 150°C junction temperature
- 5、 The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Typical Characteristics

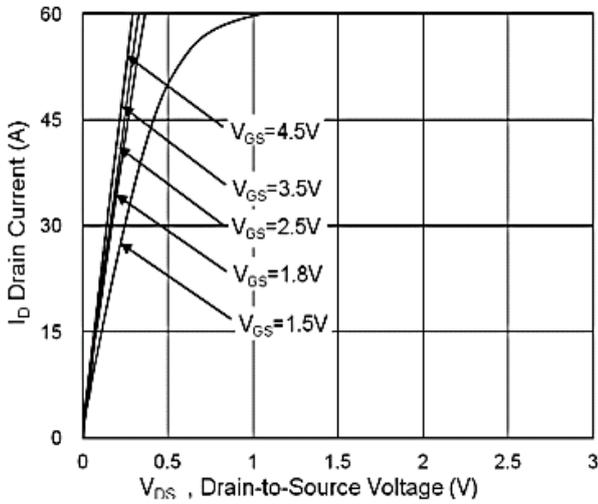


Figure.1 Typical Output Characteristics

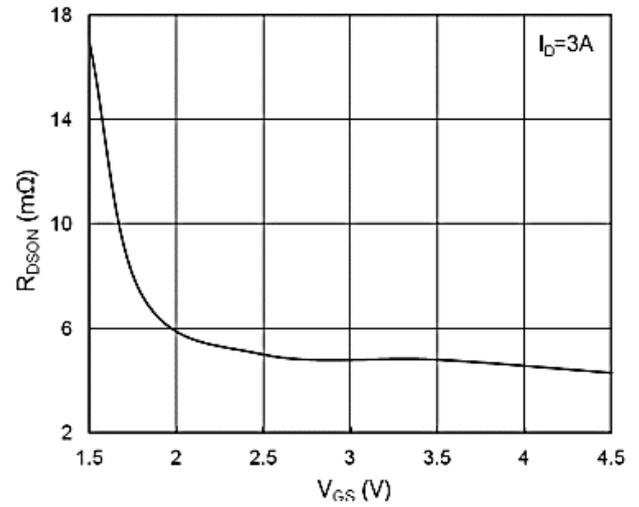


Figure.2 On-Resistance vs. Gate-Source

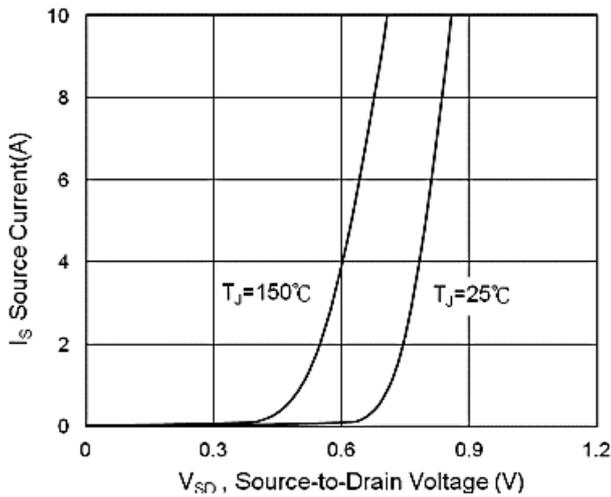


Figure.3 Forward Characteristics Of Reverse

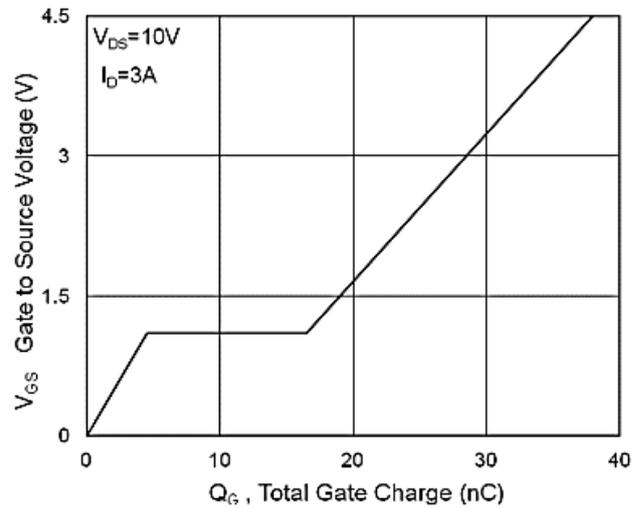


Figure.4 Gate-Charge Characteristics

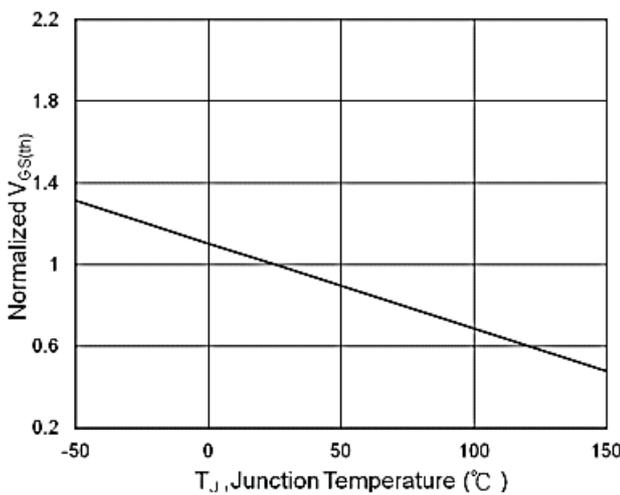


Figure.5 VGS(th) vs. Tj

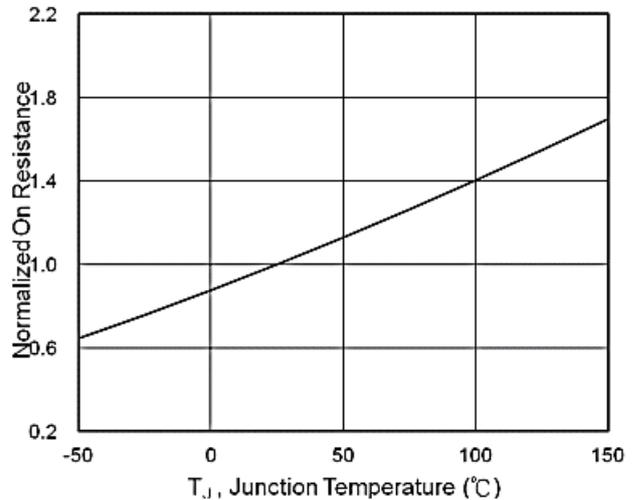


Figure.6 Normalized Rds(on) vs. Tj

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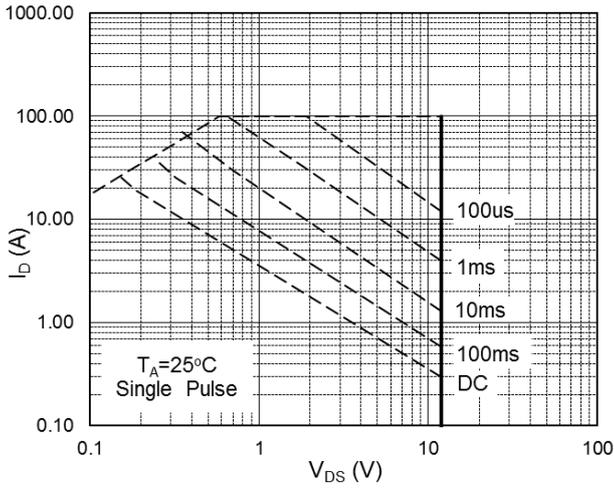


Figure.7 Capacitance

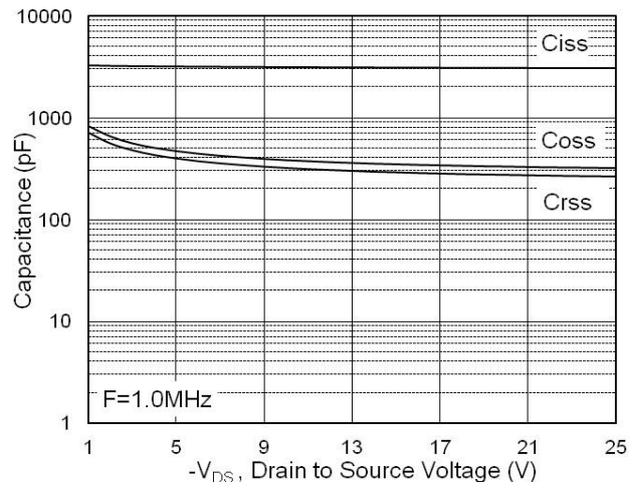


Figure.8 Safe Operating Area

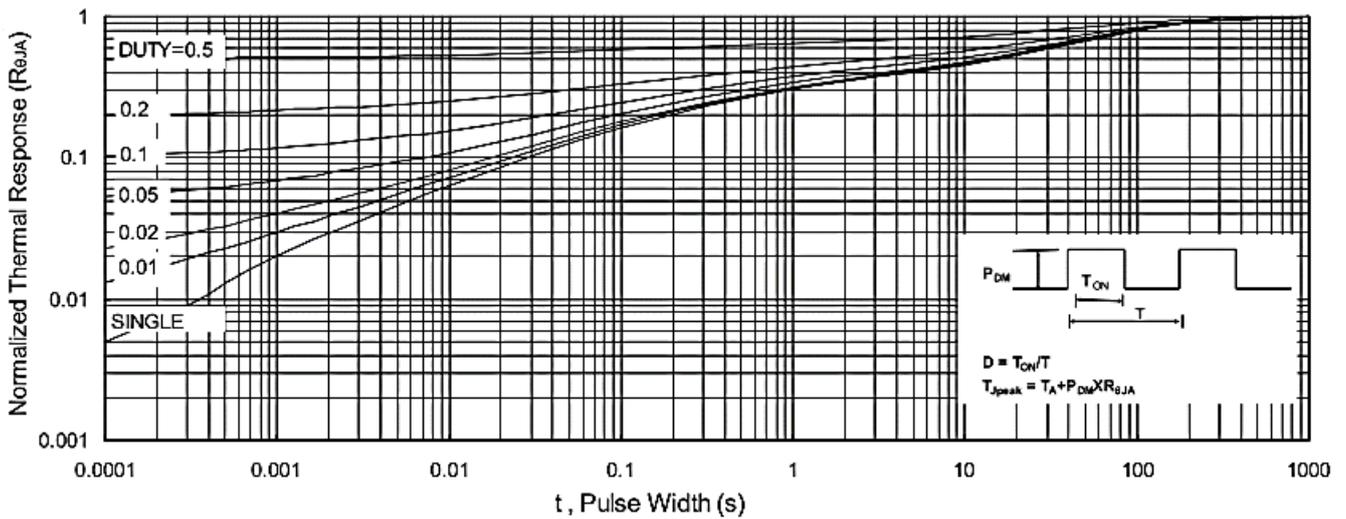


Figure.9 Normalized Maximum Transient Thermal Impedance

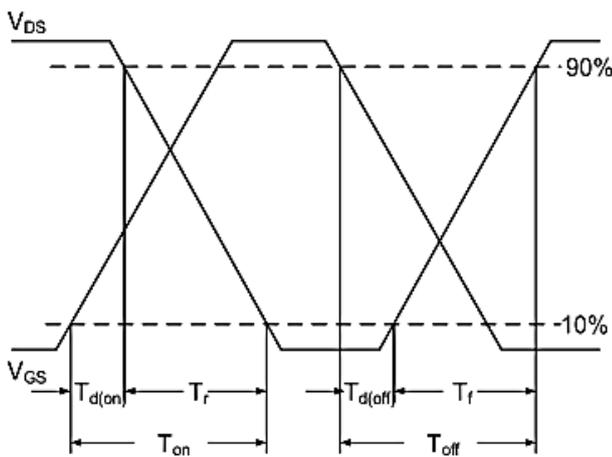


Fig.10 Switching Time Waveform

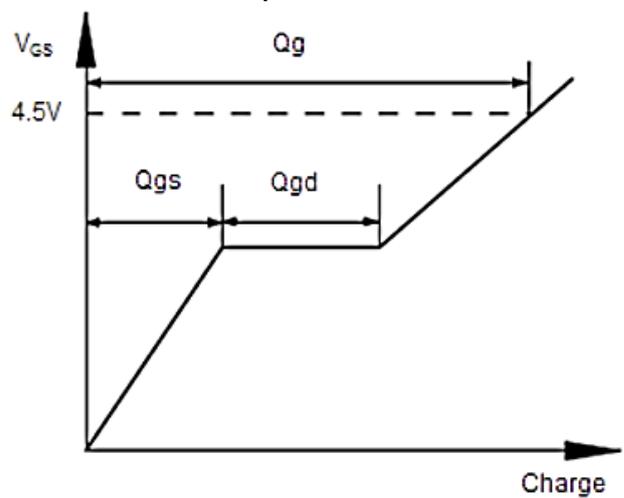
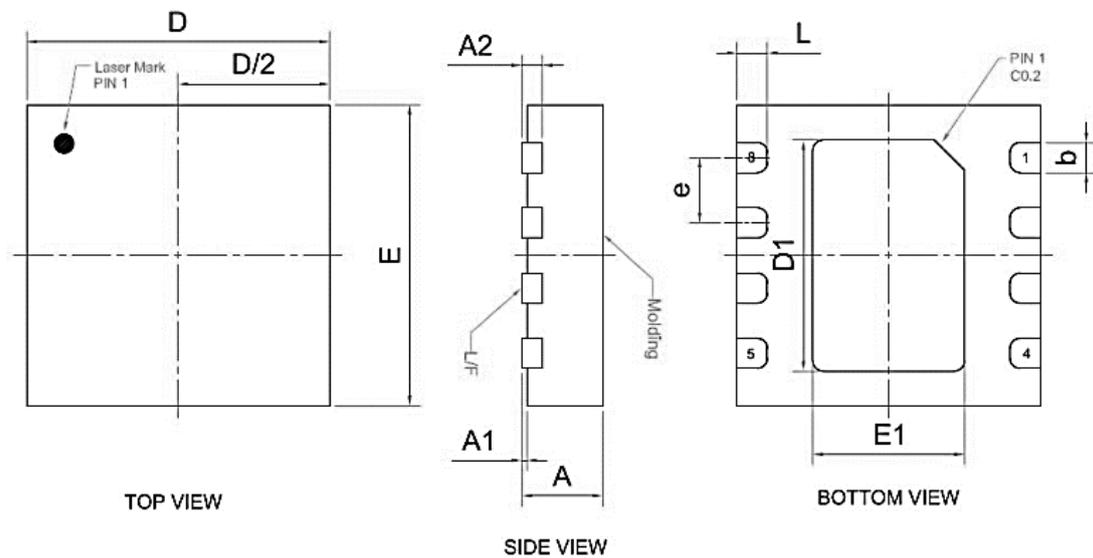


Fig.11 Gate Charge Waveform

Package Mechanical Data-DFN3X3-8L


Symbol	Dim in mm	
	Min	Max
A	0.70	0.80
A1	0.00	0.05
A2	0.203REF	
b	0.25	0.35
D	2.90	3.10
E	2.90	3.10
D1	2.20	2.40
E1	1.40	1.60
L	0.20	0.40
e	0.65BSC	

20V N+N-Channel Enhancement Mode MOSFET**Attention**

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Edition	Date	Change
REV1.0	2021/1/31	Initial release

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